TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSII)

TPC8003

Lithium Ion Battery Applications Portable Equipment Applications Notebook PC Applications

• Small footprint due to small and thin package

• Low drain–source ON resistance : RDS (ON) = 5.4 m Ω (typ.)

 $\bullet~$ High forward transfer admittance : $|\,Y_{fs}\,|\,$ = 21 S (typ.)

• Low leakage current : $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$

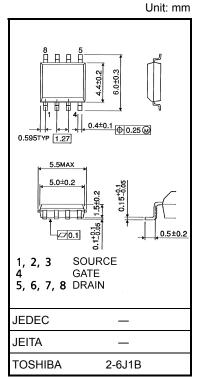
• Enhancement mode : $V_{th} = 0.8 \sim 2.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	30	V	
Drain-gate voltage (F	R _{GS} = 20 kΩ)	V_{DGR}	30	V	
Gate-source voltage		V_{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	13	Α	
Diam current	Pulse (Note 1)	I_{DP}	52		
Drain power dissipati	on (t = 10 s) (Note 2a)	P_{D}	2.4	W	
Drain power dissipation (t = 10 s) (Note 2b)		P_{D}	1.0	W	
Single pulse avalance	he energy (Note 3)	E _{AS}	220	mJ	
Avalanche current		I _{AR}	13	Α	
Repetitive avalanche (energy Note 2a) (Note 4)	E _{AR}	0.24	mJ	
Channel temperature	;	T _{ch}	150	°C	
Storage temperature	range	T _{stg}	-55 to 150	°C	

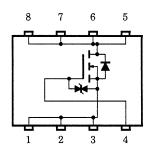
Note 1, Note 2, Note 3 and Note 4: See the next page.

This transistor is an electrostatic-sensitive device. Please handle with caution.



Weight: 0.080 g (typ.)

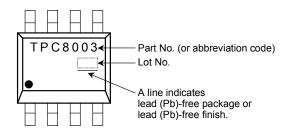
Circuit Configuration



Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	52.1	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	125	°C/W

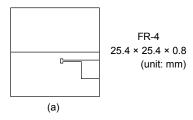
Marking (Note 5)

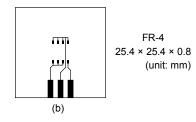


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)



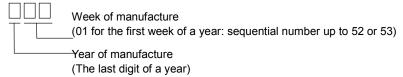


Note 3: V_{DD} = 24 V, T_{ch} = 25°C (initial), L = 1.0 mH, R_G = 25 Ω , I_{AR} = 13 A

Note 4: Reptitve rating: pulse width limited by maximum channel temperature

Note 5: ● on lower left of the marking indicates Pin 1.

Weekly code: (Three digits)



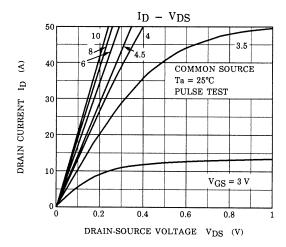
Electrical Characteristics (Ta = 25°C)

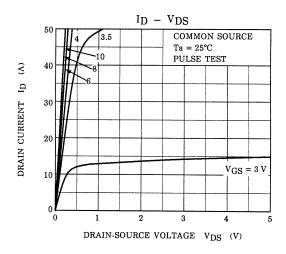
Chara	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	urrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V		_	10	μΑ
Drain-source breakdown voltage		V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	30	_	_	V
		V (BR) DSX	I _D = 10 mA, V _{GS} = -20 V	15	_	_	V
Gate threshold	voltage	V_{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.5	V
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 6.5 A	_	8.3	13	mΩ
		R _{DS (ON)}	V _{GS} = 10 V, I _D = 6.5 A	_	5.4	7	mΩ
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 6.5 A	10.5	21	_	S
Input capacitano	ce	C _{iss}			4380	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	500	_	pF
Output capacitance		Coss		_	890	_	
Switching time	Rise time	tr	$V_{GS} \stackrel{10 \text{ V}}{_{0 \text{ V}}} \stackrel{I_{D} = 6.5 \text{ A}}{\underset{\text{V}}{_{OUT}}} \\ V_{CS} \stackrel{\text{O}}{_{0 \text{ V}}} \stackrel{\text{O}}{\underset{\text{V}}{_{100}}} = 15 \text{ V}$ $V_{DD} = 15 \text{ V}$ $Duty \leq 1\%, t_{W} = 10 \mu \text{s}$	_	14	_	
	Turn-on time	t _{on}		l	27	ı	ns
	Fall time	t _f		-	72	_	115
	Turn-off time	t _{off}		_	235	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	90		_
Gate-source charge		Q _{gs}	$V_{DD} \approx 24 \text{ V, } V_{GS} = 10 \text{ V, } I_D = 13 \text{ A}$	_	60	_	nC
Gate-drain ("miller") charge		Q_{gd}			30	_	

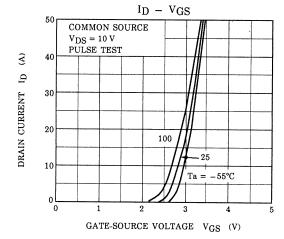
Source-Drain Ratings and Characteristics (Ta = 25°C)

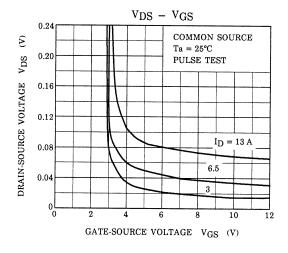
Charact	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	52	Α
Forward voltage (diode)		V _{DSF}	I _{DR} = 13 A, V _{GS} = 0 V	_	_	-1.2	V

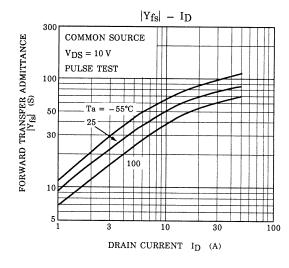
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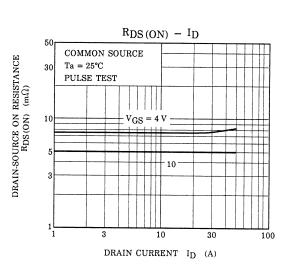




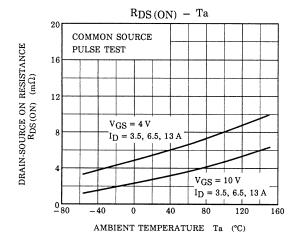


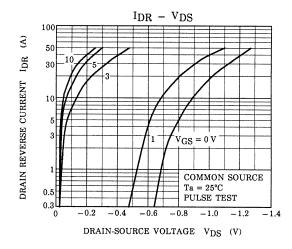


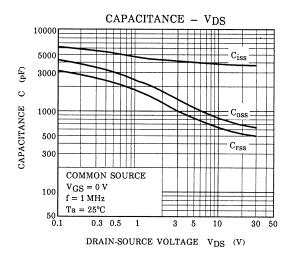


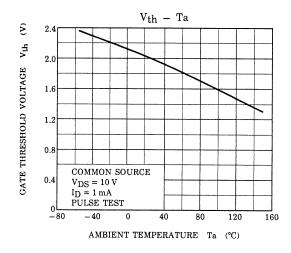


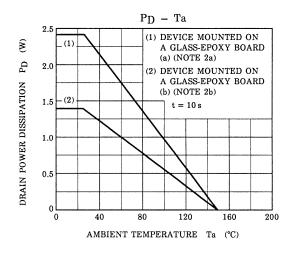
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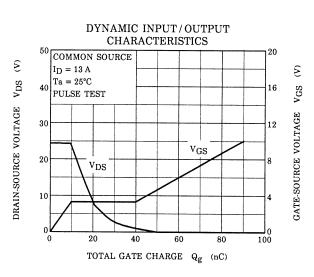


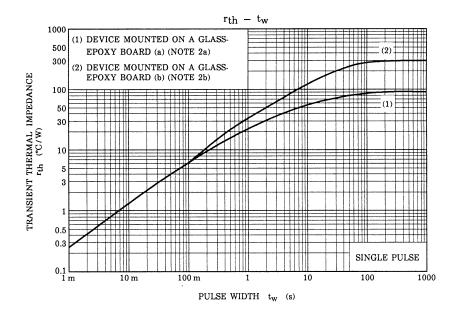


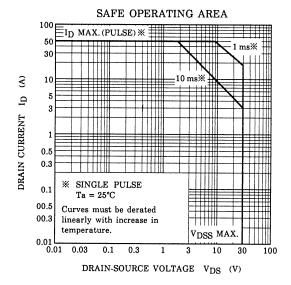


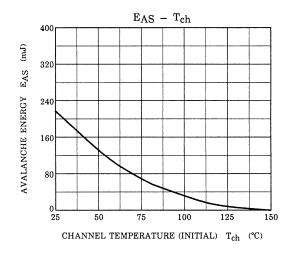


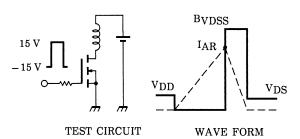












$$\begin{array}{l} T_{ch} = 25^{\circ}\text{C (Initial)} \\ \text{Peak I}_{AR} = 13 \text{ A, R}_{G} = 25 \, \Omega \end{array} \quad E_{AS} = \frac{1}{2} \cdot L \cdot I^{2} \cdot (\, \frac{\text{BVDSS}}{\text{BVDSS} - \text{VDD}}) \\ \text{VDD} = 24 \, \text{V, L} = 1.0 \, \text{mH} \end{array}$$

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